

**Notice of References Cited**

Application/Control No.

09/724,770

Applicant(s)/Patent Under

Reexamination

DUECK ET AL.

Examiner

Chih-Cheng Glen Kao

Art Unit

2882

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,799,118	08-1998	Ogusu et al.	385/14
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
X	U	Jamieson, "Thermal effects in optical systems", Optical Engineering, March/April 1981, Vol. 20, No. 2, pps. 156-160.
X	V	Olivieri et al., "Analysis of defocusing thermal effects in optical systems", Proc. of SPIE Vol. 2774, Design and Engineering of Optical Systems, ed. JJ Bratt (Aug 1996), pps. 283-292.
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.